Notice of References Cited Application/Control No. 09/695,869 Examiner Chanh Nguyen Applicant(s)/Patent Under Reexamination SHINO ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,939,828	08-1999	Matsuzaki et al.	313/584
	В	US-6,275,203	08-2001	Yamada, Hachiro	345/60
	C	US-6,288,692	09-2001	Kanazawa et al.	345/67
	D	US-6,320,326	11-2001	Shino et al.	315/169.4
	Е	US-6,344,841	02-2002	Moon, Seong Hak	345/60
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			·
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р			*			
	Q						
	R						
	s						
	Т						

NON-PATENT DOCUMENTS

	NON-FATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V						
	w						
	×						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.